

<b>Notice of References Cited</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/020,892	TANAKA ET AL.	
	Examiner	Art Unit	
	Duyen M. Doan	2152	Page 1 of 1

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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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